Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/656,182	MCTEER, ALLEN
Examiner	Art Unit

Eugene Lee

2815

SEARCHED					
Class	Subclass	Date	Examiner		
257	770,774	11/15/2005	EL		
257	762-764	11/15/2005	EL		
- · · · · · · · · · · · · · · · · · · ·					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		<u>.</u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
searched EAST, USPAT, JPO, EPO	11/15/2005	EL		
		41		